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Application/Control No.	Applicant(s)/Patent under Reexamination	
09/847,063	ZHOU ET AL.	
Examiner	Art Unit	
J. Derek Rutten	2192	

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INT	INTERFERENCE SEARCHED		
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SEARCH NO (INCLUDING SEARCH		
	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	11/28/2006	JDR
Tuan Dam (consulted re. 103)	11/28/2006	JDR
Tuan Dam (consulted re. Finality)	12/27/2006	JDR
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